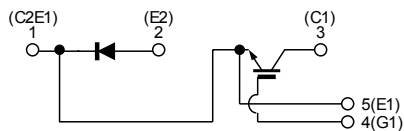
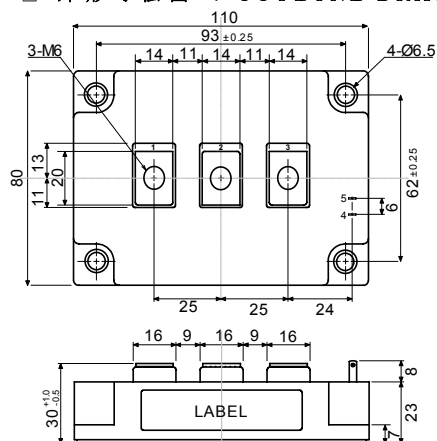
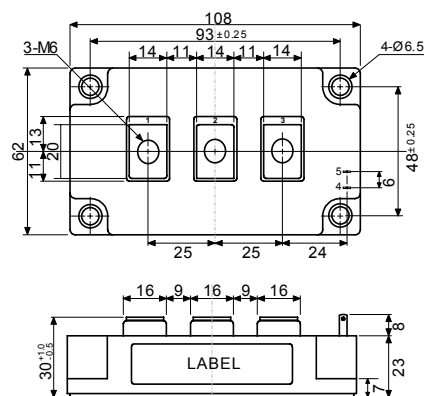


□ 回路図 : *CIRCUIT*

☐ 外形寸法図 : *OUTLINE DRAWING*



PCHMB600F6



PCHMR600F6C

Dimension: [mm]

□ 最大定格 : *MAXIMUM RATINGS* ($T_c = 25^{\circ}\text{C}$)

I t e m		S y m b o l	R a t e d V a l u e	U n i t
コレクタ・エミッタ間電圧 Collector-Emitter Voltage		V_{CES}	6 0 0	V
ゲート・エミッタ間電圧 Gate-Emitter Voltage		V_{GES}	$\pm 2 0$	V
コレクタ電流 Collector Current	DC	I_C	6 0 0	A
	1 m s	I_{CP}	1, 2 0 0	
コレクタ損失 Collector Power Dissipation		P_C	2, 0 8 0	W
接合温度 Junction Temperature Range		T_j	$-40 \sim +150$	$^{\circ}\text{C}$
保存温度 Storage Temperature Range		T_{stg}	$-40 \sim +125$	$^{\circ}\text{C}$
絶縁耐圧(Terminal to Base AC, 1 minute) Isolation Voltage		V_{ISO}	2, 5 0 0	$V_{(RMS)}$
締め付けトルク Mounting Torque	Module Base to Heatsink	F_{tor}	3 (30. 6)	$N \cdot m$ (kgf·cm)
	Busbar to Main Terminal			

□ 電 氣 的 特 性 : *ELECTRICAL CHARACTERISTICS* ($T_c = 25^{\circ}\text{C}$)

Characteristic		Symbol	Test Condition	Min.	TYP.	Max.	Unit
コレクタ遮断電流 Collector-Emitter Cut-Off Current		I_{CES}	$V_{CE} = 600V, V_{GE} = 0V$	—	—	1.0	mA
ゲート漏れ電流 Gate-Emitter Leakage Current		I_{GES}	$V_{GE} = \pm 20V, V_{CE} = 0V$	—	—	1.0	μA
コレクタ・エミッタ間飽和電圧 Collector-Emitter Saturation Voltage		$V_{CE(sat)}$	$I_C = 600A, V_{GE} = 15V$	—	2.1	2.6	V
ゲートしきい値電圧 Gate-Emitter Threshold Voltage		$V_{GE(th)}$	$V_{CE} = 5V, I_C = 600mA$	4.0	—	8.0	V
入力容量 Input Capacitance		C_{ies}	$V_{CE} = 10V, V_{GE} = 0V, f = 1MHz$	—	30,000	—	pF
スイッチング時間 Switching Time	上昇時間 Rise Time	t_r	$V_{CC} = 300V$	—	0.15	0.35	μs
	ターンオン時間 Turn-on Time	t_{on}	$R_L = 0.5\Omega$	—	0.30	0.85	
	下降時間 Fall Time	t_f	$R_G = 2.0\Omega$	—	0.10	0.25	
	ターンオフ時間 Turn-off Time	t_{off}	$V_{GE} = \pm 15V$	—	0.40	0.80	

□フリーホイーリングダイオードの特性: *FREE WHEELING DIODE RATINGS & CHARACTERISTICS* ($T_c = 25^\circ\text{C}$)

I t e m		S y m b o l	R a t e d V a l u e	U n i t
順 電 流 Forward Current	DC	I_F	6 0 0	A
	1 m s	I_{FM}	1, 2 0 0	

Characteristic	Symbol	Test Condition	Min.	Typ.	Max.	Unit
順電壓 Peak Forward Voltage	V_F	$I_F = 600A, V_{GE} = 0V$	—	1.9	2.4	V
逆回復時間 Reverse Recovery Time	t_{rr}	$I_F = 600A, V_{GE} = -10V$ $di/dt = 1200A/\mu s$	—	0.15	0.25	μs

□ 熱 的 特 性 : *THERMAL CHARACTERISTICS*

Characteristic		Symbol	Test Condition	Min.	Typ.	Max.	Unit
熱 抵 抗 Thermal Impedance	I G B T	R _{th(j-c)}	Junction to Case (T _c 測定点チップ直下)	—	—	0.06	°C/W
	Diode			—	—	0.14	

Fig.1- Output Characteristics (Typical)

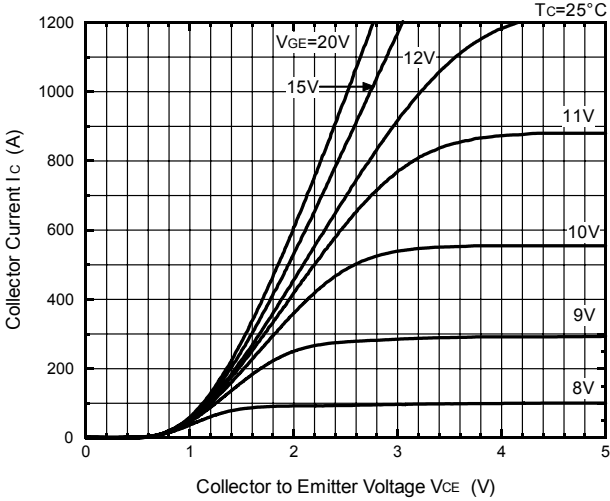


Fig.2- Output Characteristics (Typical)

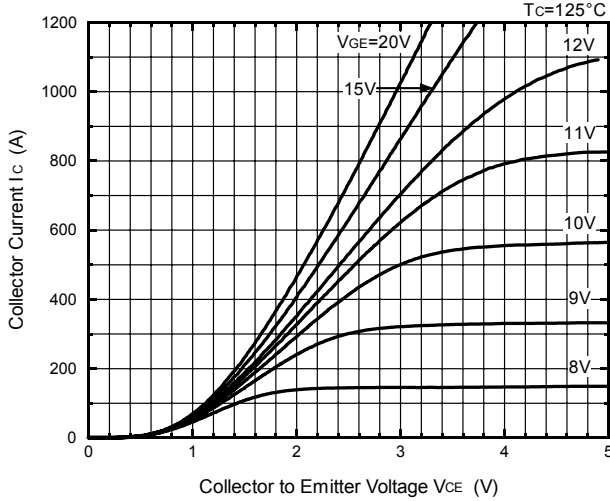


Fig.3- Collector to Emitter On Voltage vs. Gate to Emitter Voltage (Typical)

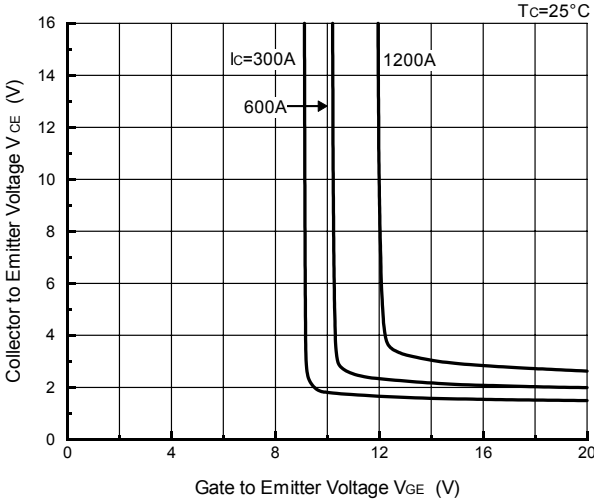


Fig.4- Collector to Emitter On Voltage vs. Gate to Emitter Voltage (Typical)

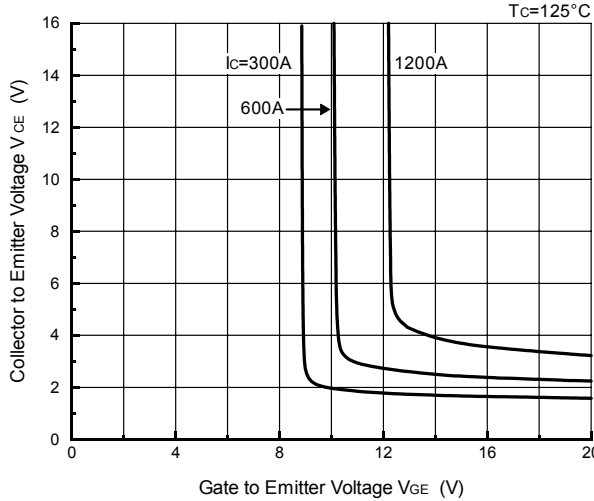


Fig.5- Gate Charge vs. Collector to Emitter Voltage (Typical)

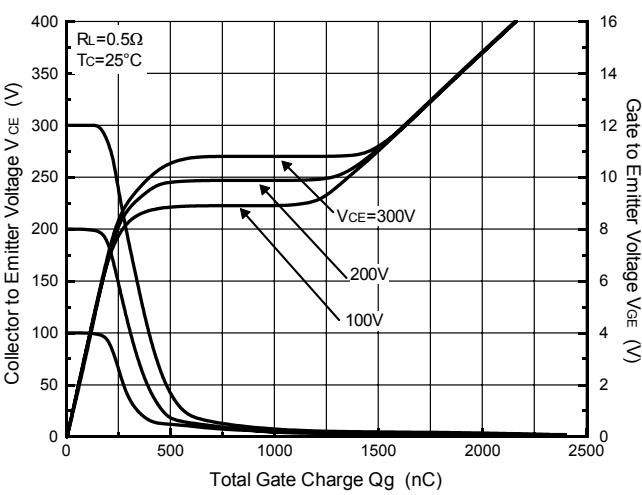


Fig.6- Capacitance vs. Collector to Emitter Voltage (Typical)

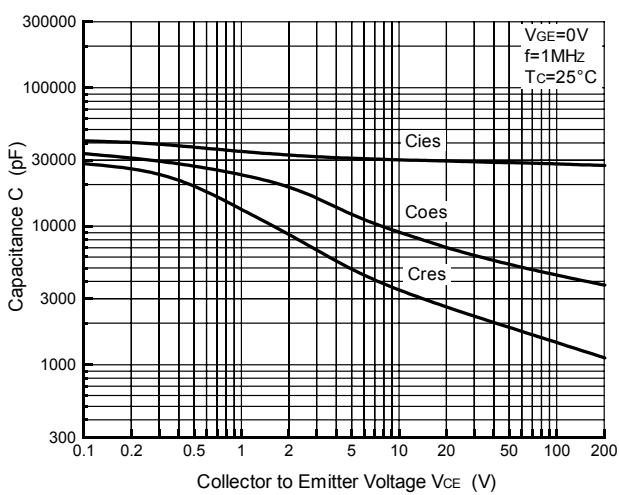


Fig.7- Collector Current vs. Switching Time (Typical)

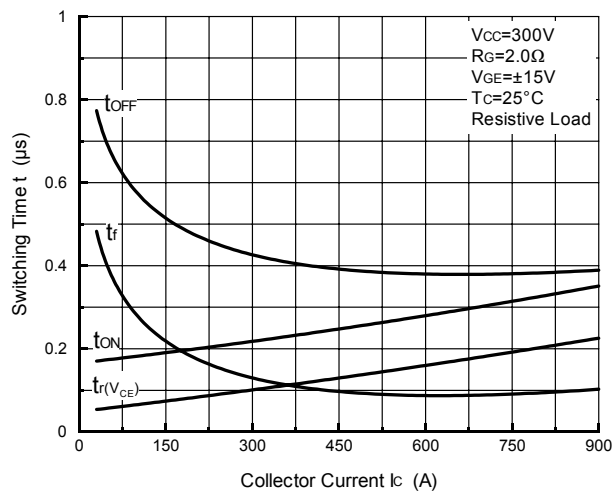


Fig.8- Series Gate Impedance vs. Switching Time (Typical)

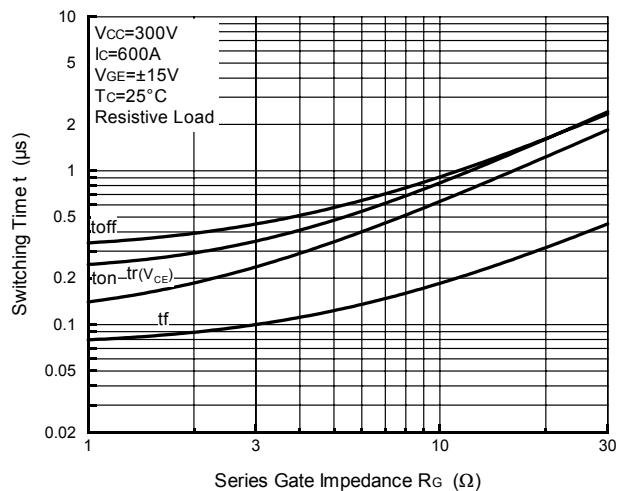


Fig.9- Collector Current vs. Switching Time

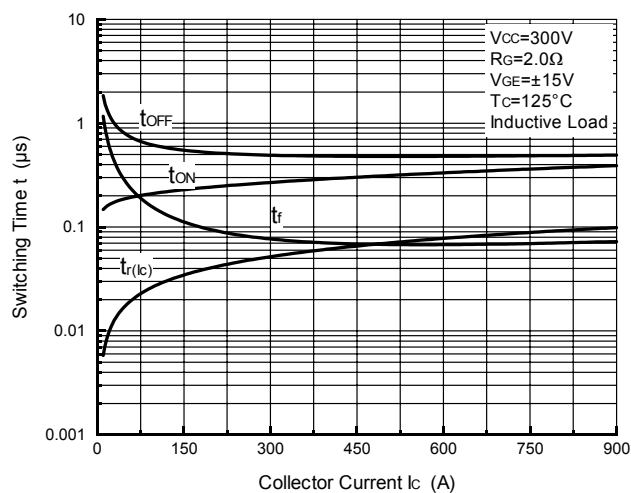


Fig.10- Series Gate Impedance vs. Switching Time

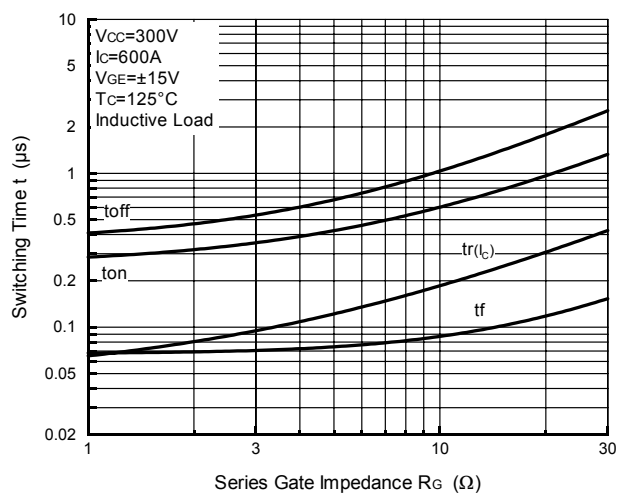


Fig.11- Collector Current vs. Switching Loss

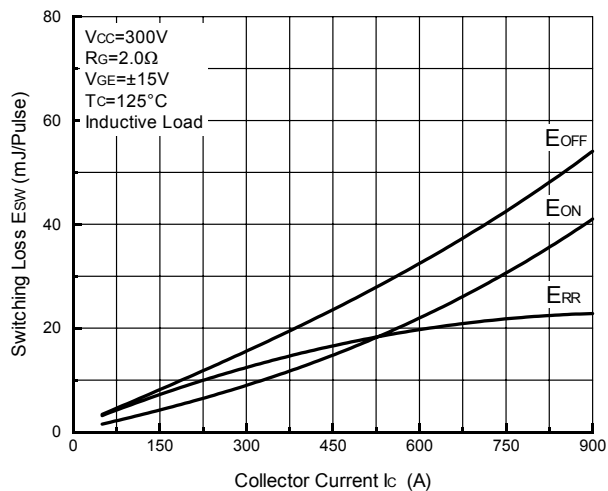


Fig.12- Series Gate Impedance vs. Switching Loss

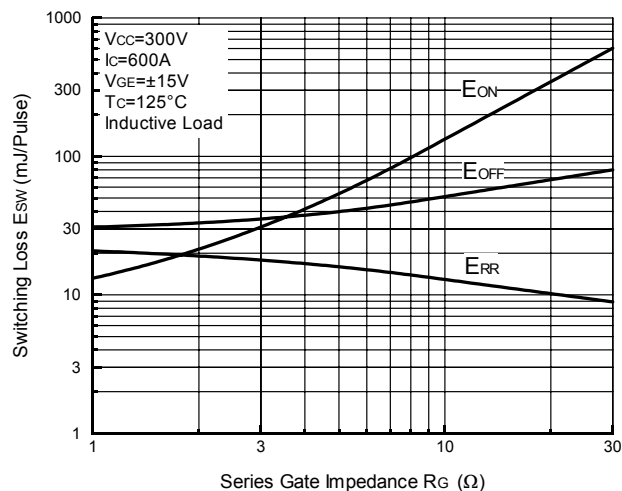


Fig.13- Forward Characteristics of Free Wheeling Diode (Typical)

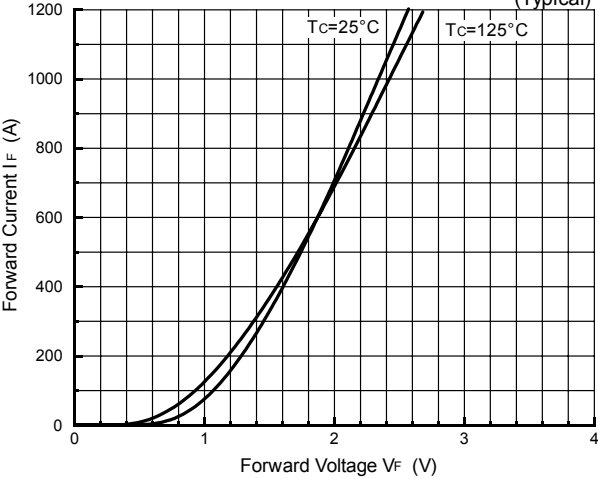


Fig.14- Reverse Recovery Characteristics (Typical)

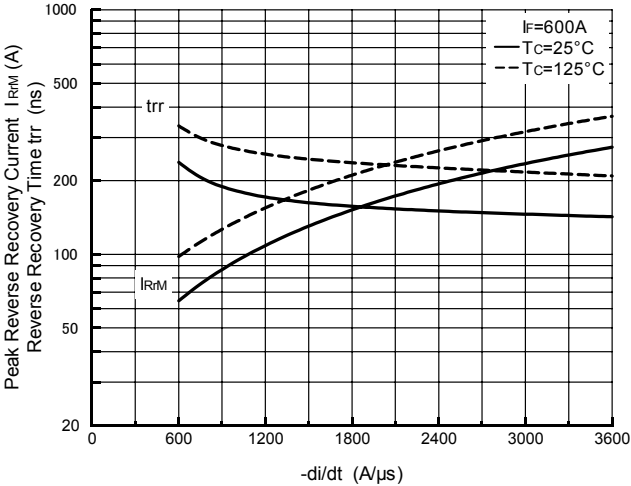


Fig.15- Reverse Bias Safe Operating Area

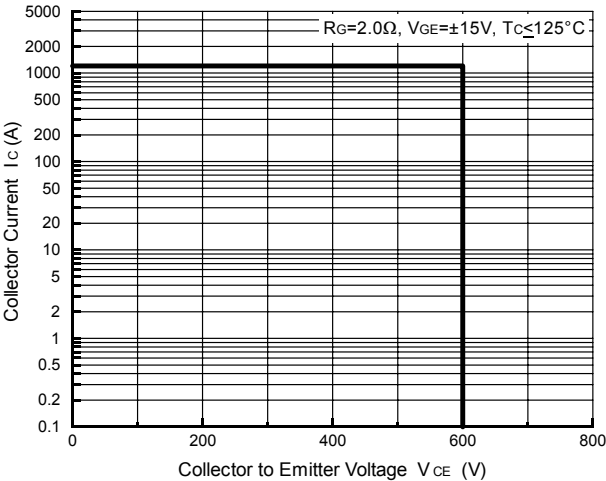


Fig.16- Transient Thermal Impedance

